

PROGRAM

March 30, 2011 (Wed.)

- 14:00-18:00 **Registration**
- 18:00-20:00 **Welcome Reception**

March 31, 2011 (Thu.)

- 8:40-9:00 **Opening of the Conference**

Session I. Advanced TCAD Technology for Nano Devices I

Chair : Prof. Asen Asenov

- 09:00-09:30 I-01 Computational Electronics in the 21st Century: Status, Challenges and Opportunities
Mark Lundstrom
*Network for Computational Nanotechnology and Birck Nanotechnology Center,
Purdue University, West Lafayette, USA*
- 09:30-10:00 I-02 Transient Simulation of the Electrical Double Layer: a New Path to Bio-sensing
Jun-Myoung Woo, Seok Hyang Kim, Jin Hong Ahn and Young June Park
Department of Electrical and Computer Engineering, Seoul National University, Korea
- 10:00-10:30 I-03 Density-Gradient Modeling and Complex Bandstructure Simulation of Tunneling Current in
Device Simulation
Zhiping Yu
Institute of Microelectronics, Tsinghua University, Beijing, China
- 10:30-11:00 **Coffee Break**

Session II. Advanced TCAD Technology for Nano Devices II

Chair : Prof. Young June Park

- 11:00-11:30 I-04 Simulation of Statistical Variability and Reliability
Asen Asenov
Department of Electrical Engineering, University of Glasgow, Glasgow, UK
- 11:30-12:00 I-05 Development and Challenge on 3D Device and Process Simulation
Yasuyuki Okura
Semiconductor Leading Edge Technologies, Inc., Tsukuba, Japan
- 12:00-12:30 I-06 Advanced TCAD Modeling of Channel Mobility and External Resistance for 20nm-node CMOS Technology and Beyond
Seong-Dong Kim
Semiconductor R&D Center, IBM, NY, USA
- 12:30-14:00 **Lunch**

Session III. Advanced TCAD Technology for Nano Devices III

Chair : Prof. Mark Lundstrom

- 14:00-14:30 I-07 Advanced TCAD Simulation Beyond 1x nm Devices
Y. K. Park, H. S. Ahn, J. C. Kim, S. J. Kim, J. H. Kim, S. M. Kim and Y. W. Kwon
CAE Team, Semiconductor Division, Samsung Electronics, Korea
- 14:30-15:00 I-08 The Role of Technology CAD for Developing Present and Future Nano-Devices
Terry Ma, Victor Moroz, Ric Borges and Lee Smith
Synopsys, Inc., Mountain View, CA, USA
- 15:00-15:30 I-09 First Principle Studies on Interface Models for HfO₂ Gate Stack
Yongjin Park, Ki-jeong Kong, Hyunju Chang and Mincheol Shin*
Advanced Materials Division, Korea Research Institute of Chemical Technology, Daejeon, Korea
**Department of Electrical Engineering, KAIST, Daejeon, Korea*
- 15:30-16:00 I-10 Nanodesign and Simulations toward Nanoelectronic Devices
Sang Uck Lee
Corporate R&D, LG Chem., Ltd., Research Park, Daejeon, Korea

16:00-16:30 **Coffee Break**

Session IV. Computational Research for Integrated Circuit Materials

Chair : Prof. Heiji Watanabe

16:30-17:00 I-11 Role of O-vacancy Defects in Devices Based on High-*k* Dielectrics and Amorphous Oxide Semiconductors

*Kee Joo Chang, Byungki Ryu, Hyeon-Kyun Noh and Eun-Ae Choi**

Department of Physics, Korea Advanced Institute of Science and Technology, Daejeon, Korea

**CAE Team, Memory Division, Samsung Electronics, Hwasung, Korea*

17:00-17:30 I-12 Computation of Capacitance at Nanometer Scale Using Orbital Partition Approach

Shusuke Kasamatsu¹, Seungwu Han², and Satoshi Watanabe¹

¹Department of Materials Engineering, The University of Tokyo, Tokyo, Japan

²Department of Materials Science and Engineering, Seoul National University, Seoul, Korea

Session V. Poster Session

Chair : Dr. Kwang-Ryeol Lee and Prof. Yuan Ping Feng

17:30-19:00 **Poster Session**

19:00-21:00 **Banquet (B.B.Q Restaurant 'B.B.Q. Garden')**

April 1, 2011 (Fri.)

Session VI. Transport Simulation for Nano and Molecular Devices I

Chair : Prof. Hiroshi Mizuseki

09:00-09:30 I-13 Quantum Transport of Holes in Nanoscale FETs: Dependence on Channel Orientation and Impact of Heavy-hole Light-hole Coupling

Mincheol Shin,

Department of Electrical Engineering, KAIST, Daejeon, Korea

- 09:30-10:00 I-14 Simulations on Time-varying Nanoscale Electronic Transport
S. Watanabe¹, W. Liu¹, D. Hirai¹, K. Sasaoka^{1,2} and T. Yamamoto¹
¹Department of Materials Engineering, the University of Tokyo, Tokyo, Japan
²Center for Computational Sciences, University of Tsukuba, Tsukuba, Japan
- 10:00-10:30 I-15 Self-energy Corrected Scattering-state Approach for Electrical and Thermal Transport Properties in Nanostructures
Hyung Joon Choi
Department of Physics and IPAP, Yonsei University, Seoul, Korea
- 10:30-11:00 **Coffee Break**

Session VII. Transport Simulation for Nano and Molecular Devices II

Chair : Prof. Hyung Joon Choi

- 11:00-11:30 I-16 First-principles Study on Transport Properties of Nanoscale Conjugated Molecules
H. Mizuseki and Y. Kawazoe
Institute of Materials Research, Tohoku University, Sendai, Japan
- 11:30-12:00 I-17 Resolving Controversies on the Multiple Conductance Peaks in Single-Molecule Junction Experiments by Multiscale Simulations
Hu Sung Kim and Yong-Hoon Kim
Graduate School of EEWS, Korea Advanced Institute of Science and Technology, Daejeon, Korea
- 12:00-12:30 I-18 Transport Behavior in Kane-Mele Graphene Nanoribbons
Chen Hao
Physics Department, Fudan University, Shanghai, China
- 12:30-14:00 **Lunch**

Session VIII. Novel Materials for Next Generation Devices I

Chair : Prof. Vijay Kumar

- 14:00-14:30 I-19 How to Predict New Novel Materials for Next Generation Devices with Theoretical Confidence?
Y. Kawazoe
Institute of Materials Research, Tohoku University, Sendai, Japan
- 14:30-15:00 I-20 Anomalous Current Flow Patterns in Defected Carbon Nanotubes
Jisoon Ihm, Youngkuk Kim and Minsung Kim
Department of Physics and Astronomy, Seoul National University, Seoul, Korea
- 15:00-15:30 I-21 Simulation Design of Nanowires for Thermoelectric Device Applications
Gang Zhang
Key Laboratory for the Physics and Chemistry of Nanodevices and Department of Electronics, Peking University, Beijing, China
- 15:30-16:00 I-22 Atomic Structure and Band Gap Engineering in Graphene-BN Hybrid Nanostructures
Prashant P. Shinde and Vijay Kumar
Dr. Vijay Kumar Foundation, Haryana, India
- 16:00-16:30 **Coffee Break**

Session XI. Novel Materials for Next Generation Devices II

Chair : Prof. Young Woo Son

- 16:30-17:00 I-23 How to Functionalize Boron Nitride Sheet and Nanotube for Device Applications
G. P. Das
Indian Association for the Cultivation of Science, Jadavpur, Kolkata, India
- 17:00-17:30 I-24 Graphene-Based Spin Logic Gates
Minggang Zeng^{1,2}, Lei Shen¹, Haibin Su^{3,4}, Miao Zhou¹, Chun Zhang^{1,5} and Yuan Ping Feng¹
¹Department of Physics, National University of Singapore, Singapore
²NanoCore, National University of Singapore, Singapore
³Division of Materials Science, Nanyang Technological University, Singapore
⁴Institute of High Performance Computing, Singapore
⁵Department of Chemistry, National University of Singapore, Singapore

17:30-18:00 I-25 Graphitic Systems under External Perturbations: Energy Gaps and Electronic Topological Transition
Young-Woo Son
School of Computational Science, Korea Institute for Advanced Study, Seoul, Korea

April 2, 2011 (Sat.)

Session III Process Optimization by Computer Simulation I

Chair : Prof. Scott Dunham

09:00-09:30 I-26 Understanding and Control of Metal-Oxide-Semiconductor Interfaces for Advanced Nanoelectronics
Heiji Watanabe¹, Takuji Hosoi¹, Takayoshi Shimura¹, Kenji Shiraishi² and Keisaku Yamada²
¹*Graduate School of Engineering, Osaka University, Osaka, Japan*
²*Graduate School of Pure and Applied Sciences, University of Tsukuba, Tsukuba, Japan*

09:30-10:00 I-27 Atomistic Stochastic Simulation of Front End Process
Alexander Schmidt, Hyo-Shin Ahn, Inkook Jang, Taikyung Kim and Young-Kwan Park
CAE Team, Semiconductor R&D Center, Samsung Electronics, Korea

10:00-10:30 I-28 Force Field Approaches for Modeling Oxide-Semiconductor Interfaces
Takanobu Watanabe^{1,2}
¹*Faculty of Science and Engineering, Waseda University, Japan*
²*Institute of Nanoscience and Nanotechnology, Waseda University, Japan*

10:30-11:00 **Coffee Break**

Session III Process Optimization by Computer Simulation II

Chair : Prof. Takanobu Watanabe

11:00-11:30 I-29 Atomistic Modeling of Nanodevice Fabrication
Scott T. Dunham and Renyu Chen
Department of Electrical Engineering, University of Washington, Seattle, USA

- 11:30-12:00 I-30 On Possibility for New Interface State of Si-dot Surrounded by Oxide
H. Watanabe
Department of Electrical Engineering, National Chiao Tung University, Taiwan
- 12:00-12:30 I-31 Reactive Molecular Dynamics Simulation of Oxide Formation on Silicon
Mauludi Ariesto, Byung-Hyun Kim, Gyubong Kim and Kwang-Ryeol Lee
Computational Science Center, Korea Institute of Science and Technology, Seoul, Korea
- 12:30-12:40 **Closing of Technical Sessions**
- 12:40-14:00 **Lunch**
- 14:00-17:00 **Guided Walking Tour of Jeju Olle-gil**

POSTER PRESENTATIONS

March 31, 2011 (Thu.)

- P-01** Density functional theory determination of the electronic structure of zinc blende InN under high pressure
G. Zheng^{1,2*}, J. Y. Guo^{1,2}, X. C. Wang^{1,2}
¹ School of Mathematics and Physics, China University of Geosciences, Wuhan 430074, China
² Institute of material modeling and computational physics, China University of Geosciences, Wuhan 430074, China
- P-02** Molecular Dynamics Analysis of Nanotube-Based Nanoelectromechanical Memory Element
Jeong Won Kang^{1*}, Jong Won Woon², Ho Jung Hwang²
¹ Department of Computer Engineering, Chungju National University, Chungju 380-702, Korea
² School of Electrical and Electronic Engineering, Chung-Ang University, Korea
- P-03** Electronic Band Structure of Si Nanosheets under External Strain
Mina Park^{1*}, Gyubong Kim¹, Kwang-Ryeol Lee¹
¹ Computational Science Center, KIST, Korea
- P-04** Effects of minimal perturbations on the energy-gap opening and the effective mass in graphene
Joon-Suh Park^{1*}, Hyoung Joon Choi¹
¹ Department of Physics and IPAP, Yonsei University
- P-05** Field-Induced Recovery of Massless Dirac Fermions in Epitaxial Graphene on SiC
Hyunjun Lee^{1*}, Seungchul Kim², Jisoon Ihm², Young-Woo Son³, Hyoung Joon Choi¹
¹ Department of Physics and IPAP, Yonsei University, Korea
² Department of Physics and Astronomy, Seoul National University, Korea
³ Korea Institute for Advanced Study, Korea
- P-06** Single-Impurity Scattering and Carrier Mobility in Doped Ge/Si Core-Shell Nanowires
Hyunjun Lee^{*}, Hyoung Joon Choi
Department of Physics and IPAP, Yonsei University, Korea
- P-07** Atomistic simulations on static and dynamic properties of dislocations in bcc Fe
Jong Bae Jeon^{*}, Byeong Joo Lee, Young Won Chang
Department of Materials Science and Engineering, POSTECH, Korea

- P-08** Local atomistic configuration effects on piezoelectric properties of $\text{La}_3\text{Ta}_{0.5}\text{Ga}_{5.5}\text{O}_{14}$ and a new piezoelectric crystal design
C.-Y. Chung^{1*}, R. Yaokawa², H. Mizuseki¹, Y. Kawazoe¹
¹ Institute for materials research, Tohoku University, Japan
² Citizen Holdings Co. LTD., Japan
- P-09** Spin Reorientation of Fe/MgO(001) System by the Formation of Oxygen Vacancy Row: an Ab Initio Study
Heechae Choi^{*} and Yong-Chae Chung
Department of Materials Science and Engineering, Hanyang University, Seoul 133-791 Korea
- P-10** Molecular dynamics simulation of the reconstruction of Si (111) surface by the constrained annealing treatment
Haining Cao^{1,2*}, Kwang-Ryeol Lee¹, Byung-Hyun Kim¹, Mauludi Ariesto Pamungkas¹, M. Joe¹
¹ Computational Science Center, Korea Institute of Science and Technology, Republic of Korea
² International R&D Academy, University of Science and Technology, Daejeon 305-333, Republic of Korea
- P-11** Reactive Molecular Dynamics Simulation of Early Stage of Dry Oxidation of Si (001) Surface
Mauludi Ariesto Pamungkas^{1,2*}, Minwoong Joe¹, Byung-Hyun Kim¹, Gyubong Kim¹, and Kwang-Ryeol Lee^{1,2}
¹ Computational Science Center, Korea Institute of Science and Technology, Republic of Korea
² International R&D Academy, University of Science and Technology, Daejeon 305-333, Republic of Korea
- P-12** Atomic-Scale Study of Nanocontact-induced Surface Defects in Iron and Copper
Chansun Shin^{1*}, Hyung-ha Jin¹, Junhyun Kwon¹, Yuri Osetsky²
¹ Nuclear Materials Division, Korea Atomic Energy Research Institute, Daejeon, Korea
² Materials Science and Technology Division, Oak Ridge National Laboratory, Oak Ridge, TN 37831, USA
- P-13** Molecular dynamics study of porous carbon growth for low-k materials
M. Joe^{1*}, M.-W. Moon¹, and K.-R. Lee¹
¹ Computational Science Center, Korea Institute of Science and Technology, Seoul, Korea
- P-14** Conduction in Disordered 3-D Topological Insulators
V. Sacksteder^{1*}, S. Kettemann², X. Dai³, Z. Fong³, Q. Wu³
¹ Institute of Physics, Chinese Academy of Sciences, Beijing 100190
² School of Engineering and Science, Jacobs University Bremen, Bremen 28759, Germany, and Division of Advanced Materials Science, Pohang University of Science and Technology (POSTECH), San31, Hyoja-dong, Nam-gu, Pohang 790-784, South Korea
³ Beijing National Laboratory for Condensed Matter Physics, and Institute of Physics, Chinese Academy of Sciences, Beijing 100190, China

- P-15** Theoretical DFT Study on Structure and Chemical Activity of Transition Metal Oxides, Carbon K4 and Metal-Organic Framework IRMOF Structures
Nurbosyn U. Zhanpeisov
*Institute for International Education & Department of Chemistry,
Graduate School of Science, Tohoku University, Sendai 980-8576, Japan*
- P-16** First principle study on interaction between various metals and C atom in Me-Carbon System
Xiao-Wei Li^{1,2*}, Ai-Ying Wang¹, and Kwang-Ryeol Lee²
¹ *Ningbo Institute of Materials Technology and Engineering, CAS, Ningbo, P.R. China*
² *Computational Science Center, KIST, Seoul, Korea*
- P-17** Stability of donor-pair defects in Si_{1-x}Ge_x alloy nanowires
Ji-Sang Park^{1*}, Byungki Ryu², and Kee Joo Chang¹
¹ *Department of Physics, Korea Advanced Institute of Science and Technology, Daejeon, Korea*
² *Samsung Advanced Institute of Technology, Suwon, Korea*
- P-18** Stability of boron dopants near the interface between Si and amorphous SiO₂
Y. J. Oh^{*}, H. K. Noh, and K. J. Chang
Department of Physics, Korea Advanced Institute of Science and Technology, Korea
- P-19** First principle studies of Si/SiO₂/HfO₂ interface in MOSFET device
Yongjin Park^{1*}, Ki-jeong Kong¹, Hyunju Chang¹, and Mincheol Shin²
¹ *Advanced Materials Div., Korea Research Institute of Chemical Technology, Korea*
² *Dept. of Electrical Engineering, KAIST, Korea*
- P-20** Understanding transient-enhanced boron diffusion in silicon by Molecular Dynamics simulations in Ultra-Shallow Junction (USJ) formation
Chansoo Kim^{1*}, Byung-Joo Lee², Kwang-Ryeol Lee¹
¹ *Computational Science Center, KIST, Korea*
² *Materials Science and Engineering, POSTECH, Korea*
- P-21** Molecular Dynamics Simulation Study of Silicon Nanowires Oxidation
Byung-Hyun Kim^{1,2*}, Gyubong Kim¹, Mina Park¹, Mauludi Ariesto Pamungkas^{1,3}, Kwang-Ryeol Lee¹, and Yong-Chae Chung²
¹ *Computational Science Center, Interdisciplinary Fusion Technology Division, KIST, Korea*
² *Department of Materials Science and Engineering, Hanyang University, Korea*
³ *Department of Nanomaterial Science and Technology, University of Science and Technology, Korea*

P-22 Atomic Scale Investigation of the Si/SiO_x Interface in Silicon Nanowire

Byung-Hyun Kim^{1,2*}, Gyubong Kim¹, Mina Park¹, Mauludi Ariesto Pamungkas^{1,3}, Kwang-Ryeol Lee¹, and Yong-Chae Chung²

¹ Computational Science Center, Interdisciplinary Fusion Technology Division, KIST, Korea

² Department of Materials Science and Engineering, Hanyang University, Korea

³ Department of Nanomaterial Science and Technology, University of Science and Technology, Korea

P-23 Introduction to the Joint Research Project for the Development of Molecular Simulation Technology for Nano Devices

Kwang-Ryeol Lee¹, Hyunju Chang², Mincheol Shin³ and Kee Joo Chang⁴

¹ Computational Science Center, Interdisciplinary Fusion Technology Division, KIST, Korea

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